Sea	rch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/657,100	ARAKAWA, TAKEHARU	
Examiner	Art Unit	_
Khai M. Nguyen	2687	

-	SEAR	CHED	
Class	Subclass	Date	Examiner
455	566 550.1 73 457 414.1 414.3	11/25/2005	
100			

INI	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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(INCLUDING SEAR	NOTES CH STRATEGY	()
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